

Notice of References Cited	Application/Control No. 10/665,725		Applicant(s)/Patent Under Reexamination LIEW ET AL.	
	Examiner JOHN F. RAMIREZ		Art Unit 3737	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,306,822 B1	10-2001	Kumagai et al.	514/7
*	C	US-6,442,287 B1	08-2002	Jiang et al.	382/128
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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